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October 2024

FDB0105N407L

N-Channel PowerTrench[®] MOSFET 40 V, 460 A, 0.8 m Ω

Features

- Max $r_{DS(on)}$ = 0.8 m Ω at V_{GS} = 10 V, I_D = 50 A
- Max $r_{DS(on)}$ = 1.1 m Ω at V_{GS} = 6 V, I_D = 42 A
- Fast Switching Speed
- Low Gate Charge
- \blacksquare High Performance Trench Technology for Extremely Low $R_{DS(on)}$
- High Power and Current Handling Capability
- RoHS Compliant

General Description

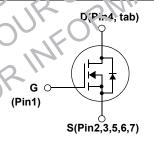
This N-Channel MOSFET is produced using Fairchild Semiconductor's advance PowerTrench® process that has been especially tailored to minimize the on-state resistance while maintaining superior ruggedness and switching performance for industrial applications

Applications

- Industrial Motor Drive
- Industrial Power Sonly
- Industrial A: mation.
- Battery pera ! tools
- E ~v Pr rctio.
- So. Inv.
- PS 1 Energy Inverters
- Ei rgy Storage
- Load Svitce







N. Aximum Ratings To = 25 °C vin ess otherwise noted.

m' 1	Paramete	r		Ratings	Units
V _{DS}	Drain to Source Voltage			40	V
V_{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous	T _C = 25°C	(Note 5)	460	
<u>-</u>	-Continuous	T _C = 100°C	(Note 5)	330	Α
	-Pulsed		(Note 4)	2540	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	1109	mJ
D	Power Dissipation	$T_C = 25^{\circ}C$		300	w
P_{D}	Power Dissipation	T _A = 25°C	(Note 1a)	3.8	VV
T _J , T _{STG}	Operating and Storage Junction Temperatur	e Range		-55 to +175	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Note 1)	0.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	40	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDB0105N407L	FDB0105N407L	D2-PAK-7L	330mm	24mm	800 units

Electrical Characteristics T_J = 25 °C unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25 °C		13		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 32 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V			±100	nA

On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2	2.8	4	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C				mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 50 \text{ A}$ $V_{GS} = 6 \text{ V}, I_D = 42 \text{ A}$		6).8 1.1	rnΩ
		V _{GS} = 10 V, I _D = 50 A, T _J = 15 C		1	1.8	
9 _{FS}	Forward Transconductance	V _{DS} = 10 V, I _D = 50 A		286	\overline{N}	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V = 26 (V		16500	23100	pF
C _{oss}	Output Capacitance	f = 1 .4z	-	5335	7470	pF
C _{rss}	Reverse Transfer Capacitance	112,712		7/3	1565	pF
R_g	Gate Resistance			2.6		Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time	45	73	ns
t _r	Rise Time $V_{DD} = 20 \text{ V/ } I_D = 50 \text{ A},$	69	110	ns
t _{d(off)}	Turn-Off Delay Time $V_{CS} = 10 \text{ V}, R_{GEN} = 9 \Omega$	117	186	ns
t _f	Fall Time	61	97	ns
Q_g	Total Gate C rige	208	291	nC
Q _{gs}	Gr to source Sate (arge $V_{DD} = 20 \text{ V}, I_D = 50 \text{ A},$	64		nC
Q _{gd}	G "Miller Charge	29		nC

9 Characteristics

	M. 'mum Continuous Drain to Source Diode Forward Current		-	460	Α
I _{Sh}	Maximu n Pulsed Drain to Source Dicate Forward Current	-	-	2540	Α
V _{SD}	Source to Drain Diode Forward Voltage V _{GS} = 0 V, I _S = 50 A (Note 2)		0.8	1.2	V
t _{rr}	Reverse Recovery Time I _E = 50 A, di/dt = 100 A/us		107	171	ns
Q _{rr}	Reverse Recovery Cl ar le		119	191	nC

R_{0,IC} is the sum of the junction (o-C asc and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0,IC} is guaranteed by design will e_{N₀CA} is determined by the user's board design.

a) 40 °C/W when mounted on a 1 in 2 pad of 2 oz copper. b) 62.5 °C/W when mounted on a minimum pad of 2 oz copper.

^{2.} Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0 %.

^{3.} E_{AS} of 1109 mJ is based on starting T_J = 25 °C, L = 0.3 mH, I_{AS} = 86 A, V_{DD} = 10 V, V_{GS} = 36 V. 100% test at L = 0.1 mH, I_{AS} = 125 A.

^{4.} Pulsed Id please refer to Figure "Forward Bias Safe Operating Area" for more details.

^{5.} Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

Typical Characteristics $T_J = 25 \, ^{\circ}\text{C}$ unless otherwise noted.

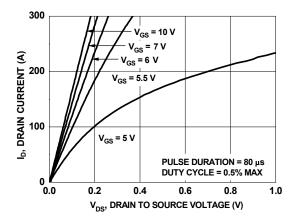
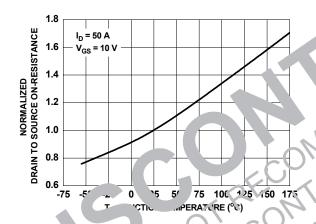


Figure 1. On Region Characteristics



Tui 3. Normalized On Resistance
Junction Temperature

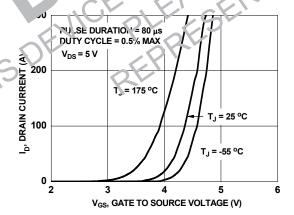


Figure 5. Transfer Characteristics

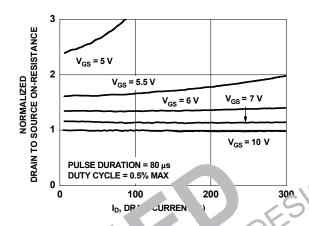


Figure 2. N ma ed C Resistance vs. rain C ren u Gate Voltage

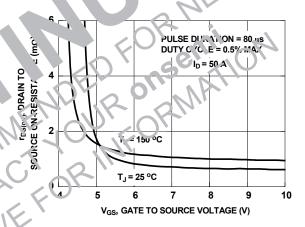


Figure 4. On-Resistance vs. Gate to Source Voltage

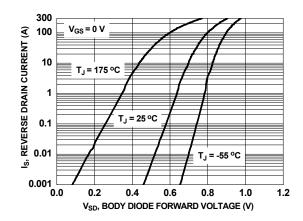


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted.

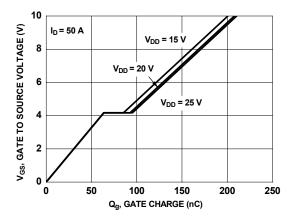


Figure 7. Gate Charge Characteristics

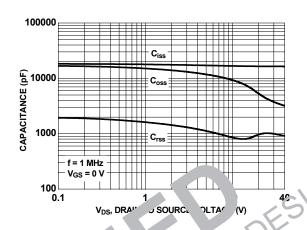


Figure 8. apa ar vs. Drain to urc voltage

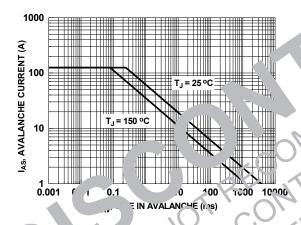


Fig. e9. Unclamped Inductive Switching Capability

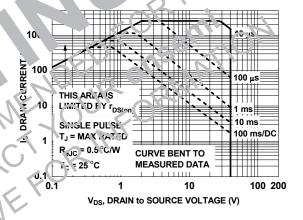


Figure 10. Forward Bias Safe Operating Area

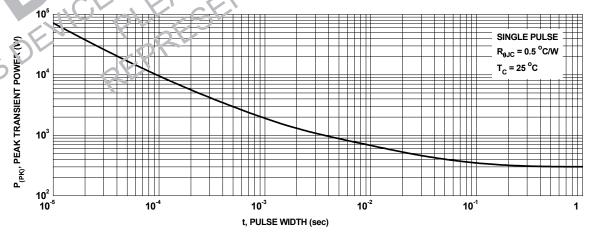


Figure 11. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25$ °C unless otherwise noted.

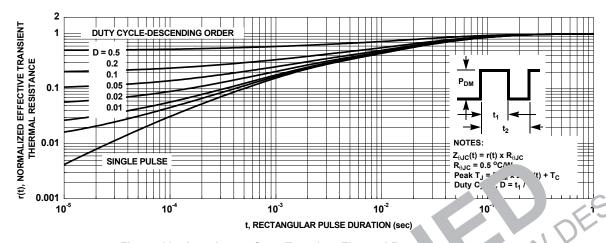
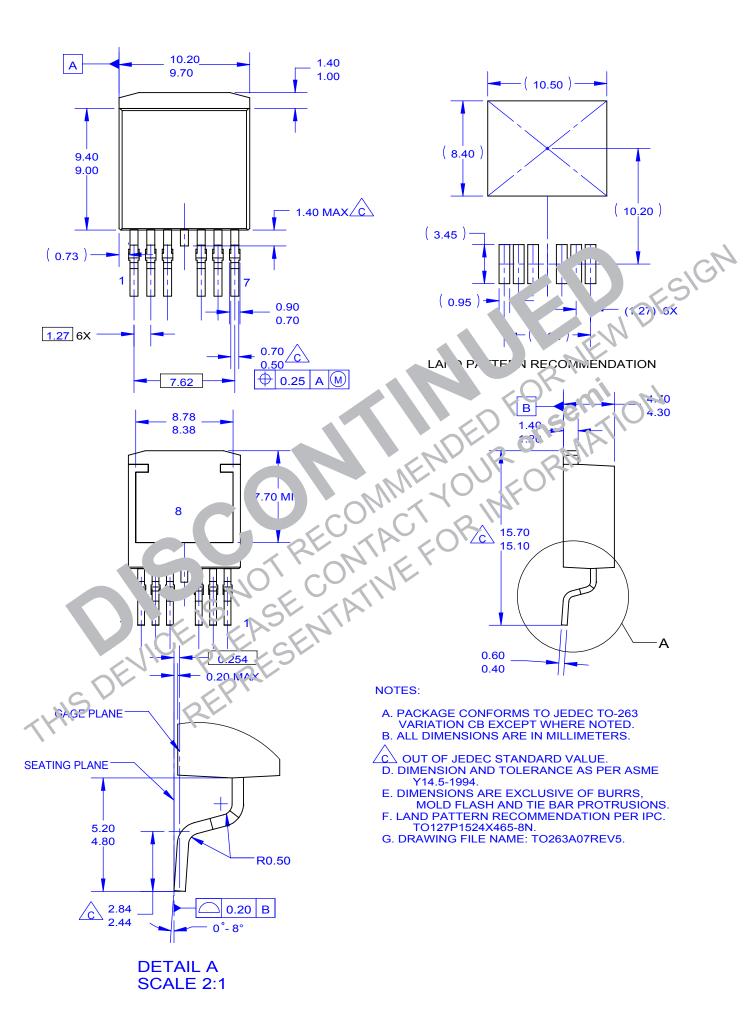


Figure 12. Junction-to-Case Transient Thermal Resp. se my





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